Notification Number: 20220711001.0 Notification Date: July 22, 2022 Title: Datasheet for DRV8243-Q1, DRV8244-Q1, and DRV8245-Q1 Customer Contact: PCN Manager Dept: Quality Service Change Type: Design Design Wafer Bump Site Assembly Site Design Wafer Bump Material Assembly Process Data Sheet Wafer Bump Material Assembly Materials Part number change Wafer Bump Process Mechanical Specification Test Site Wafer Fab Site Packing/Shipping/Labeling Test Process Wafer Fab Materials Part number change Wafer Fab Materials Notification Details Description of Change: Texas Instruments Incorporated is announcing an information only notification. The product datasheet(s) is being updated as summarized below. The following change history provides further details. DRV824 INSTRUMENTS SUNSQ23B - DECEMBER 2021 - REVISED JULY Changes from Revision A (January 2022) to Revision B (July 2022) Device comparison - Removed pre-production information, slew rate and off-state diagnostics feature exceptions for DRV8245HRXZQ1 and DRV8244SRYJQ1. Corrected pin name typo for PH/IN2. EC table - R _{LVI,3ol5} for MODE pin increased to 250 KΩ minimum. EC table - Updated typical R _{ON} values. Typical characteristics - Corrected FET RON plot, improved A _{IPROPI} plot. Block diagram for P-variant - Corrected VDD pin typo. Feature description for PWM mode - Removed pre-production information.						
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Feature description for Register - Pin control - Removed pre-production information						
Feature description for SR - Removed pre-production information and duplication of SR tables (Refer EC)						
table instead)						
Feature description for ITRIP regulation - Removed pre-production information, added note on linear ITRIP						
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Feature description for DIAG pin (HW variant only) - Corrected behavior for LVL5 setting						
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Functional states - Removed pre-production information						
SDO frame - Removed pre-production information						
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The datasheet number will be changing.

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Device Family	Change From:	Change To:
DRV8243-Q1	SLVSG23A	SLVSG23B
DRV8244-Q1	SLVSG24A	SLVSG24B
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These changes may be reviewed at the datasheet links provided.

https://www.ti.com/product/DRV8243-Q1 https://www.ti.com/product/DRV8244-Q1 https://www.ti.com/product/DRV8245-Q1

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Reason for Change:

To accurately reflect device characteristics.

Anticipated impact on Fit, Form, Function, Quality or Reliability (positive / negative):

No anticipated impact. This is a specification change announcement only. There are no changes to the actual device.

Changes to product identification resulting from this notification:

None.

Product Affected:			
DRV8245HQRXZRQ1	DRV8243HQRXYRQ1	DRV8244SQRYJRQ1	

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